

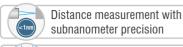
More Precision

interferoMETER // Ultra-precise white light interferometers



Absolute distance measurement with subnanometer resolution

interferoMETER 5600-DS



Best-in-Class: Resolution < 30 picometers

Absolute measurement, suitable for step profiles

Compact and robust sensors with large offset distance

Measuring rate up to 6 kHz for high speed measurements

INTER Ethernet / EtherCAT / RS422 / PROFINET / EtherNet/IP



Designed for high-resolution distance measurements in clean rooms & vacuums

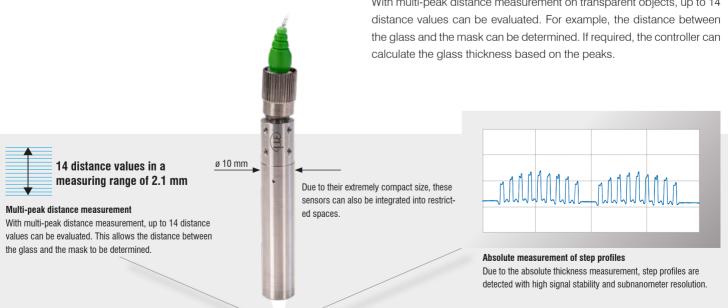
The white light interferometer IMS5600-DS is used for distance measurements with the highest precision. The controller offers a special calibration with intelligent evaluation and enables absolute measurements with subnanometer resolution. The interferometer is used for measurement tasks with the highest accuracy requirements, e.g., in electronics and semiconductor production. For vacuum applications, Micro-Epsilon offers special sensors, cables and feedthrough accessories. These sensors and cables are particle-free to a high degree and can even be used in UHV.

Absolute distance measurement with large measuring range and offset distance

The IMS5600-DS is used for high-precision displacement and distance measurements. The system provides absolute measurement values and can therefore also be used for distance measurement of step profiles. Thanks to the absolute measurement, sampling is performed without signal loss. When measuring on moving objects, the differences in height of heels, steps and depressions can thus be reliably detected. The measuring system offers sub-nanometer resolution with a large offset distance in relation to the measuring range.

Multi-peak distance measurement

With multi-peak distance measurement on transparent objects, up to 14



| Model | | IMS5600-DS19 | IMS5600MP-DS19 | |
|--|---------------------------------|---|---|--|
| Measuring range | Distance | 2.1 1 | mm | |
| | Thickness | | 0.010 1.3 mm | |
| Start of measuring range | | approx. 19 mm | | |
| Resolution 1) | | < 30 pm | | |
| Measuring rate | | continuously adjustable from 100 Hz to 6 kHz | | |
| Linearity 2) | | < ±10 nm | $<\pm 10$ nm for the first distance $<\pm 100$ nm for each further distance | |
| Temperature stability | Sensor | Linearity: typ. 0.1 nm / K (w | Linearity: typ. 0.1 nm / K (without offset displacement) | |
| | Controller | temperature compensated, stability $<$ 10 ppm between +15 +35 $^{\circ}\text{C}$ | | |
| Multi-layer measurement | | - | up to 13 layers | |
| Light source | | NIR-SLED, wave Pilot laser: laser LED, | | |
| Laser class | | Class 1 according to DIN EN 60825-1: 2015-070 Pilot laser: Class 1, power (< 0.2 mW) | | |
| Light spot diameter 3) | | 10 <i>µ</i> m | | |
| Measuring angle 4) | | ±2° | | |
| Target material | | Glass, reflecting or diffuse surfaces 5) | | |
| Supply voltage | | 24 VDC ±15 % | | |
| Power consumption | | approx. 10 W (24 V) | | |
| Signal input | | Sync in, trigger in, 2x encoders (A+, A-, B+, B-, index) | | |
| Digital interface | | Ethernet / EtherCAT / RS422 / PROFINET ⁶ / EtherNet/IP ⁶ | | |
| Analog output | | 4 20 mA / 0 10 V (16 bit D/A converter) | | |
| Switching output | | Error1-Out, Error2-Out | | |
| Digital output | | sync out | | |
| Connection | Optical | Pluggable optical fiber via E2000 socket (controller) and FC socket (vacuum feedthrough); pluggable UHV optical fiber via FC socket (vacuum feedthrough and sensor); standard lengths 3 m, 5 m and 10 m; other cable lengths on request; bending radius: static 30 mm, dynamic 40 mm | | |
| | Electrical | 3-pin supply terminal strip; encoder connection (15-pin, HD-sub socket, max. cable length 3 m, 30 m with external encoder supply); RS422 connection socket (9-pin, Sub-D, max. cable length 30 m); 3-pin output terminal strip (max. cable length 30 m); 11-pin I/O terminal strip (max. cable length 30 m); RJ45 socket for Ethernet (out) / EtherCAT (in/out) (max. cable length 100 m) | | |
| Mounting | Sensor | Clamping, mounting adapter (see accessories) | | |
| | Controller | free-standing, DIN rail mounting | | |
| Temperature range | Storage | -20 +70°C | | |
| | Operation | Sensor: +5 +70 °C; Controller: +15 +35 °C | | |
| Shock (DIN EN 60068-2-27) | | | s, 1000 shocks each | |
| ibration (DIN EN 60068-2-6) 2 g / 20 500 Hz in XY axis, 10 cycles each | | Y axis, 10 cycles each | | |
| Protection class (DIN EN 60529) | Sensor | IP40 (optio | on / VAC) | |
| | Controller | IP40 | | |
| Vacuum | Optional UHV (cable and sensor) | | able and sensor) | |
| Material | Sensor | Stainless steel | | |
| | Controller | Aluminum housing, passive cooling | | |
| Control and indicator elements | | Multifunction button: two adjustable functions and reset to factory settings after 10 s; web interface for setup: selectable presets, freely selectable averaging, data reduction, setup management; 6 x color LEDs for intensity, range, SLED, pilot laser, status and power; pilot laser: can be switched on for sensor alignment | | |
| All data at apparant ambient temperature (24 ± 9.50) | | | | |

All data at constant ambient temperature (24 ± 2 °C)

1) Measuring rate 0.5 kHz, moving average over 64 values, measured differentially between the front and back of a thin glass plate in the mid of the measuring range (2 sigma)

2) Maximum deviation from reference system over entire measuring range, measured on front surface of ND filter

3) In the mid of the measuring range

4) Maximum sensor tilt angle that produces a usable signal on polished glass (n = 1.5) in the mid of the measuring range.

The accuracy decreases when approaching the limit values.

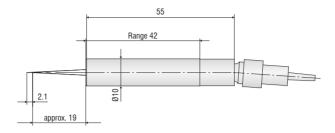
9) Non-transparent materials require optically dense surface at a wavelength of 840 nm

9) Optional connection via interface module (see accessories)

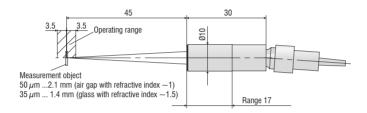
Dimensions

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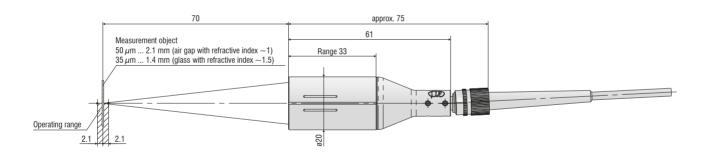
IMS5400-DS sensor



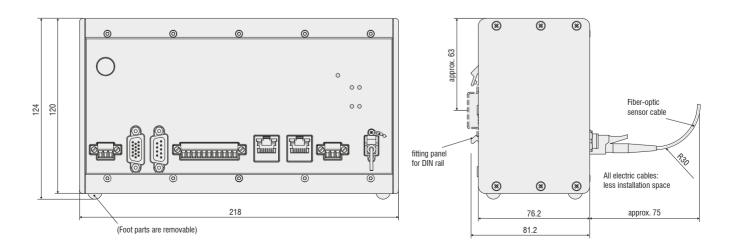
IMS5400-TH45 sensor



IMS5400-TH70 sensor



IMS5400-DS / IMS5400-TH / IMS5600-DS controllers



Accessories

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Cables

Standard E2000/APC (controller) and FC/APC connector (sensor)

C5401-2 Optical fiber, length 2 m
C5401-3 Optical fiber, length 3 m
C5401-5 Optical fiber, length 5 m
C5401-10 Optical fiber, length 10 m

Other lengths up to 20 m on request

Drag chain E2000/APC (controller) and FC/APC connector (sensor)

C5401-3(010) Optical fiber, length 3 m C5401-5(010) Optical fiber, length 5 m C5401-10(010) Optical fiber, length 10 m

Other lengths up to 20 m on request

Vacuum cable FC/APC connector

C5400-1/VAC Optical fiber, length 1 m
C5400-2/VAC Optical fiber, length 2 m
C5400-5/VAC Optical fiber, length 5 m

Flange for vacuum feed through

C5405/VAC/1/CF16 CF flange C5405/VAC/1/KF16 KF flange

Mounting Adapter

MA5400- 10 Mounting adapter for IMP-DS19/ -TH45

MA5400- 20 Mounting adapter for IMP-TH70

Other accessories

 $SC2471-x/IF2008 \qquad IMC5400/5600 \ connector \ cable+\ IF2008/PCIE, \ length \ 3\ m\ /\ 10\ m$ $SC2471-x/RS422/OE \quad IMC5400/5600 \ interface \ cable+\ IF2001/USB, \ length \ 3\ m\ /\ 10\ m$

IF2001/USB RS422/USB converter

IF2008/PCIE Interface card

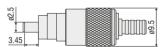
IF2030/PNET Interface module for PROFINET integration

PS2020 Power supply 24V / 2.5A EC2471-3/OE Encoder cable, 3 m

E2000/APC standard connector



FC/APC standard connector



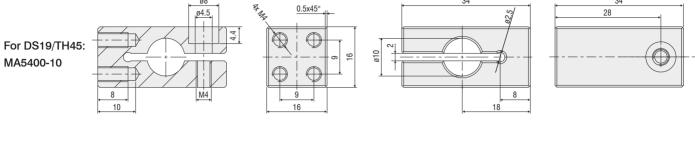


C5405/VAC/1/CF16 C5405/VAC/1/KF16

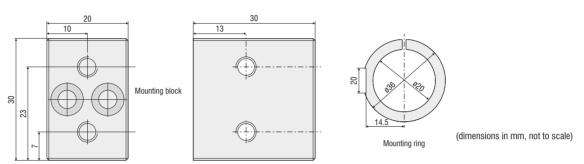
Accessories

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Sensor mounting adapter



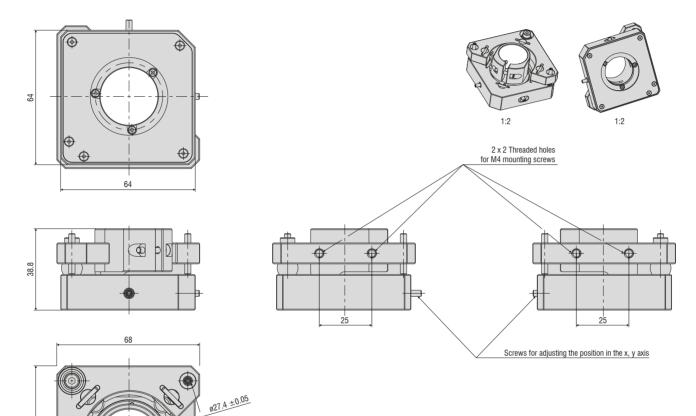




Adjustable mounting adapter

The adjustable JMA mounting adapter simplifies the alignment and fine adjustment of interferometric sensors. You can integrate the sensors with the adapter directly into the machine and then align them directly on site. This corrects, e.g, minor deviations caused by mounting and compensates for tilted measuring objects. With two-sided thickness measurements, the mounting adapter supports the fine alignment of the two measuring points.





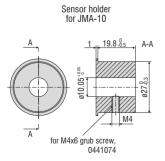
Scope of supply

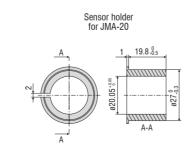
Adjustable mounting adapter

Screwdriver for positioningAssembly instructions

■ Sensor holder for sensors Ø10 and Ø20 mm

Sensor holder





Screws for tilt adjustment

Sensors and Systems from Micro-Epsilon



Sensors and systems for displacement, distance and position



Sensors and measurement devices for non-contact temperature measurement



Measuring and inspection systems for metal strips, plastics and rubber



Optical micrometers and fiber optics, measuring and test amplifiers



Color recognition sensors, LED analyzers and inline color spectrometers



3D measurement technology for dimensional testing and surface inspection